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# Dynamic conditional score patent count panel data models

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# Motivation

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The main interest of this paper is to suggest new dynamic score-driven models for measuring the relationships between R&D expenses and patent application activity.

There is an extensive body of literature on this issue (e.g., Hausman, Hall and Griliches, 1984; Blundell, Griffith and Windmeijer, 2002; Wooldridge, 2005; and many more).

All these works suggest different specifications and use different estimation methods to identify R&D-patent relationships.

# Motivation

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Recently, **score-driven dynamic econometric models** appeared.

This family of models is named **dynamic conditional score** (DCS) (Harvey and Chakravarty, 2008; Harvey, 2013) or **generalized autoregressive score** (GAS) models (Creal, Koopman and Lucas, 2008).

These are observation-driven models that can be relatively simply estimated, typically they fit well to data, and for many DCS model the asymptotic properties of maximum likelihood estimator are derived.

Different DCS time-series models were suggested for location, scale and association (Harvey, 2013). For count data, however, there is only a suggestion in Harvey (2013, Ch. 5.11).

# Contribution

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We suggest a new class of **score-driven patent count panel data models**, and investigate if the performance of these models is superior to previous patent count panel data models of the body of literature.

# Structure

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- 1. Data and variables**
- 2. Maximum likelihood estimation (MLE)**
- 3. Quasi maximum likelihood estimation (QMLE)**
- 4. Competing count panel data models**
- 5. Model diagnostics and results**
- 6. References**

# Data and variables

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# Panel data

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We use the U.S. patent and firm specific variable dataset of Blazsek and Escribano (2010 JoE, 2016 JoE).

This panel includes firm level annual data of 4476 U.S. companies for period 1979 to 2000.

Variables in this panel are indexed by firm  $i = 1, \dots, N$  and year  $t = 1, \dots, T$ .

# Observable variables

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$n_{it}$  : patent application count for firm  $i$  in year  $t$

$rd_{it}$  : log of inflation-adjusted R&D expenditure

$D_i$  : hi-tech dummy, it takes the value one for drug, computer, scientific instrument, chemical and electronic components industries, and zero otherwise

$b_i$  : firm size, log of the inflation adjusted book value for the simple midpoint year



# Observable variables

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$n_{it}$  : patent application count for firm  $i$  in year  $t$

This is the dependent variable of the model.

This is a non-negative integer number, hence the econometric model to be applied is a non-linear **count data model**.

In the literature several models were proposed for the **conditional expectation** of  $n_{it}$ , denoted by  $\lambda_{it}$ , in order to study the determinants of patent application activity.

# Maximum likelihood estimation

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# Hausman, Hall and Griliches (HHG) (1984, Econometrica)

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$$E(n_{it}|X_{it}, \alpha_i) = \lambda_{it} = \exp(X_{it}\theta) \alpha_i$$

$$X_{it}\theta = \mu_0 + \gamma_1 t + \gamma_2(t \times rd_{it}) + \gamma_3 D_i + \gamma_4 b_i + \beta_0 rd_{it} + \dots + \beta_5 rd_{it-5}$$

$X_{it}\theta$  is used to simplify notation (observable variables)

$\alpha_i > 0$  represents *unobserved and time-constant firm-specific effects*.  $\alpha_i$  captures time-constant omitted variables.

$\alpha_i$  can be considered for panel data models; which is one of their main advantage.

# Assumptions of HHG (1984)

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(ML1)  $n_{it} | (X_{i1}, \dots, X_{iT}, \alpha_i) \sim \text{Poisson}(\lambda_{it})$ . This assumption implies strict exogeneity of all explanatory variables conditional on  $\alpha_i$ .

(ML2)  $\lambda_{it}$  is modelled by the exponential function to ensure positivity, i.e.  $\lambda_{it} = \exp[X_{it}\theta]\alpha_i = \exp[X_{it}\theta + \ln \alpha_i]$ .  
Multiplicative count data model.

(ML3)  $n_{it} | (X_{i1}, \dots, X_{it}, \alpha_i)$  and  $n_{is} | (X_{i1}, \dots, X_{is}, \alpha_i)$  are independent

(ML4)  $\alpha_i$  is i.i.d. with Gamma(1,  $\delta$ ) distribution

## RE MLE and FE MLE of HHG (1984)

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Under (ML1), (ML2), (ML3) and (ML4), *random effects MLE (RE MLE)*.

For RE MLE  $\alpha_i$  is independent of  $X_{it}$ .

Under (ML1), (ML2) and (ML3), *fixed effects MLE (FE MLE)*.

For FE MLE  $\alpha_i$  may be associated with  $X_{it}$ .

Hence, FE MLE is more general than RE MLE.

# Disadvantages of MLE

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- (a) exact conditional distribution is assumed for  $n_{it} | (X_{i1}, \dots, X_{iT}, \alpha_i)$  for both RE MLE and FE MLE
- (b) exact distribution is assumed for  $\alpha_i$  for RE MLE
- (c) strict exogeneity of all explanatory variables is assumed.

Strict exogeneity implies that (i) lags of  $n_{it}$  cannot be considered as explanatory variables within  $\lambda_{it}$ ; (ii)  $n_{it}$  cannot have impact on future values of any explanatory variables, for example R&D.

# Pooled Patent count data models

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We can drop the **strict exogeneity assumption** by excluding the unobserved effects term  $\alpha_i$  from the model.

This is going to permit lags of  $n_{it}$  as explanatory variables and also we can include such explanatory variables (e.g. R&D) for which future values ( $rd_{it+1}, \dots, rd_{iT}$ ) are influenced by  $n_{it}$ .

Nevertheless, we will still need the **contemporaneous exogeneity** of explanatory variables.

Of course, dropping  $\alpha_i$  from the model is a price that we have to pay for dropping the strict exogeneity assumption.

# Pooled Patent count data models

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For the remainder, we shall see patent count data models for which  $\alpha_i$  is excluded. The general name for this kind of panel data models is **pooled count panel data models**.



# Quasi maximum likelihood estimation

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## QMLE method (Gourieroux, Monfort, Trognon, GMT, 1984 a, b, Econometrica)

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The assumptions on exact distribution and strict exogeneity question the validity of MLE for patent count panel data models.

We use an alternative estimation method that is more robust since it does not require assumptions on the exact distribution of  $n_{it} | (X_{i1}, \dots, X_{iT}, \alpha_i)$  and  $\alpha_i$ . Furthermore, the strict exogeneity assumption is also relaxed and lags of  $n_{it}$  will be permitted as explanatory variables within  $\lambda_{it}$ .

This alternative estimation method is named in the literature '**pseudo MLE**' (PMLE) or '**quasi MLE**' (QMLE).

## GMT (1984 a, b)

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QMLE, similar to MLE, provides parameter estimates by maximizing an objective function.

For MLE this objective function is the log of the joint density of  $(n_{i1}, \dots, n_{iT})$ , and it is maximized with respect to the parameters.

MLE involves an assumption about the conditional distribution of the dependent variable.

# GMT (1984 a, b)

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GMT (1984 a, b) suggests objective functions to be maximized however it is not needed to assume a specific conditional distribution for the dependent variable.

The objective functions of QMLE are log density functions of a certain class of probability distributions, named the **linear exponential family (LEF)**.

LEF density functions have a certain functional form.

# GMT (1984 a, b)

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Some examples of **discrete** and **continuous** LEF distributions:

- A)  $Y \sim \text{Binomial}(n, p)$  distribution, with given  $n$
- B)  $Y \sim \text{Poisson}(\lambda)$  distribution
- C)  $Y \sim \text{Negative binomial}(\delta, \lambda)$  distribution, with given  $\delta$
- D)  $Y \sim \text{Normal}(\mu, \sigma^2)$  distribution, with given  $\sigma$
- E)  $(Y_1, \dots, Y_K) \sim \text{Multinomial}(n, p_1, \dots, p_K)$  distribution, with given  $n$
- F)  $(Y_1, \dots, Y_K) \sim \text{Multivariate normal}(\mu, \Sigma)$ , with given  $\Sigma$

## GMT (1984 a, b)

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For each of the LEF there is the corresponding objective function to be maximized. This objective function is given by the log joint density of the LEF distribution.

However, this is a *pseudo* log likelihood, since we do not assume that data are in fact generated from the LEF, i.e. QMLE uses an auxiliary objective function in order to estimate parameters.

GMT (1984 a, b) show that the QMLE method provides consistent parameter estimates.

The QMLE method is a special case of the more general **M-estimator** (see Wooldridge, 2002, Ch. 12).

## QMLE for count data (Wooldridge, 1997a)

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Wooldridge (1997a) uses the QMLE method for cross section and panel count data. QMLE assumption:

(QMLE1)  $E[n_{it} | X_{i1}, \dots, X_{it}] = \lambda_{it}$  where  $X_{it}$  can be any observed variable. *Correct specification of the conditional expectation.*

(QMLE1) also means that contemporaneous explanatory variables are exogenous.

Result of Wooldridge (1997a) that is related to GMT (1984 a, b):

**Under (QMLE1), the pooled Poisson QMLE and also the pooled negative binomial QMLE provide consistent estimates of parameters; since both distributions are LEF.**

## QMLE for count data (Wooldridge, 1997a)

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The pooled negative binomial QMLE is **more efficient** than the pooled Poisson QMLE since the negative binomial QMLE objective function has an additional parameter ( $\delta$ ), hence it is more flexible.

However, the negative binomial QMLE assumes that  $\delta$  is already given.

Thus, for all patent count data models we apply the **two-step negative binomial QMLE procedure** suggested by Wooldridge (1997a). First step: estimate  $\delta$ . Second step: use  $\hat{\delta}$  in the negative binomial QMLE objective function to estimate the remaining parameters.



## QMLE for count data (Wooldridge, 1997a)

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This two-step negative binomial QMLE estimation procedure is directly related to the **two-step quasi-generalized pseudo MLE (QGPMLE) procedure** suggested by GMT (1984 a,b) in which the given parameter of the LEF is estimated in a first step, and remaining parameters are estimated in the second step.

# GMM estimation

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In the body of literature of count data models there exists an alternative estimation method that drops the strict exogeneity assumption: **generalized method of moments**, GMM (Hansen, 1982). (For count data: Chamberlain, 1992; Wooldridge, 1997b.)

In these models  $\alpha_i$  is also included, and it may be correlated with the explanatory variables (i.e. it is a fixed effect, FE).

We had (i) computation problems (slow iterations); (ii) for the DCS count data models suggested in this paper  $\alpha_i$  cannot be considered as it is unobservable. *Thus, we do not use GMM.*

# Competing patent count data models

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# Pooled Hausman, Hall and Griliches (1984) *finite distributed lag (FDL) model*

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$$E(n_{it}|X_{it}) = \lambda_{it} = \exp(X_{it}\theta)$$

$$X_{it}\theta = \mu_0 + \gamma_1 t + \gamma_2 (t \times rd_{it}) + \gamma_3 D_i + \gamma_4 b_i + \beta_0 rd_{it} + \dots + \beta_5 rd_{it-5}$$

Multiplicative count data model

# Pooled Wooldridge (2005)

## *exponential feedback model (EFM)*

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$$E(n_{it}|X_{it}) = \lambda_{it} = \exp[X_{it}\theta + \gamma_5 n_{i1} + \varphi_1 n_{it-1}]$$

This model considers AR(1) dynamics and also controls for the initial condition of the dynamic process ( $\gamma_5 n_{i1}$ ).

Multiplicative count data model

# Pooled Blundell, Griffith and Windmeijer (2002) *linear feedback model (LFM)*

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$$E(n_{it}|X_{it}) = \lambda_{it} = \varphi_1 n_{it-1} + \exp(Y_{it}\tilde{\theta}) \text{ with } 0 < \varphi_1 < 1$$

$$Y_{it}\tilde{\theta} = X_{it}\theta + \gamma_5 n_{i1}$$

Additive count data model

# Multiplicative DCS (MDCS) Poisson model

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Davis, Dunsmuir and Streett (2003, 2005), and Harvey (2013) suggest MLE for a dynamic model for time-series count data, updated by the score of the Poisson distribution.

*Poisson is member of LEF, hence QMLE can also be used.*

The score of  $n_{it}$  is computed with respect to  $\lambda_{it}$  as follows:

$$f(n_{it}|X_{i1}, \dots, X_{it}) = \frac{\exp(-\lambda_{it})\lambda_{it}^{n_{it}}}{n_{it}!} \quad (\text{density of Poisson})$$

$$\frac{\partial \ln f(n_{it}|X_{i1}, \dots, X_{it})}{\partial \lambda_{it}} = \frac{n_{it}}{\lambda_{it}} - 1 \equiv u_{it} > -1 \quad (\text{conditional score})$$

# Multiplicative DCS (MDCS) Poisson model

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Davis, Dunsmuir and Streett (2003, 2005); Harvey (2013) suggest dynamic models for count data in which only lags of  $u_{it}$  update the dynamic equation (i.e. MA-type terms), but they do not consider AR terms.

We extend their dynamic score-driven count data model and (i) we consider AR terms too in the dynamic equation; (ii) we suggest DCS count data models for panel data instead of time-series; (iii) we estimate the count data model by QMLE and not by MLE, hence Poisson distribution is not assumed for  $(n_{it} | X_{i1}, \dots, X_{it})$ .



# Multiplicative DCS (MDCS) Poisson model

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$$E(n_{it}|X_{it}) = \lambda_{it} = \exp(\Psi_{it} + Y_{it}\tilde{\theta})$$

MDCS-QMA( $q$ ) (Davis, Dunsmuir and Streett 2003, 2005; Harvey 2013):

$$\Psi_{it+1} = \theta_0 u_{it} + \dots + \theta_q u_{it-q}$$

MDCS-QAR(1):

$$\Psi_{it+1} = \varphi_1 \Psi_{it} + \theta_0 u_{it}$$

MDCS-QARMA( $p, q$ ):

$$\Psi_{it+1} = \varphi_1 \Psi_{it} + \dots + \varphi_p \Psi_{it-p} + \theta_0 u_{it} + \dots + \theta_q u_{it-q}$$

# Additive DCS (ADCS) Poisson model

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$$E(n_{it}|X_{it}) = \lambda_{it} = \Psi_{it} + \exp(Y_{it}\tilde{\theta})$$

ADCS-QMA( $q$ ):

$$\Psi_{it+1} = \theta^* + \theta_0 u_{it} + \dots + \theta_q u_{it-q} \text{ where } \theta^* = \theta_0 + \dots + \theta_q$$

ADCS-QAR(1):

$$\Psi_{it+1} = \theta_0 + \varphi_1 \Psi_{it} + \theta_0 u_{it}$$

ADCS-QARMA( $p, q$ ):

$$\Psi_{it+1} = \varphi_1 \Psi_{it} + \dots + \varphi_p \Psi_{it-p} + \theta_0 u_{it} + \dots + \theta_q u_{it-q} \text{ where } \theta^* = \theta_0 + \dots + \theta_q$$

# Diagnosics and results

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# Diagnostics and results

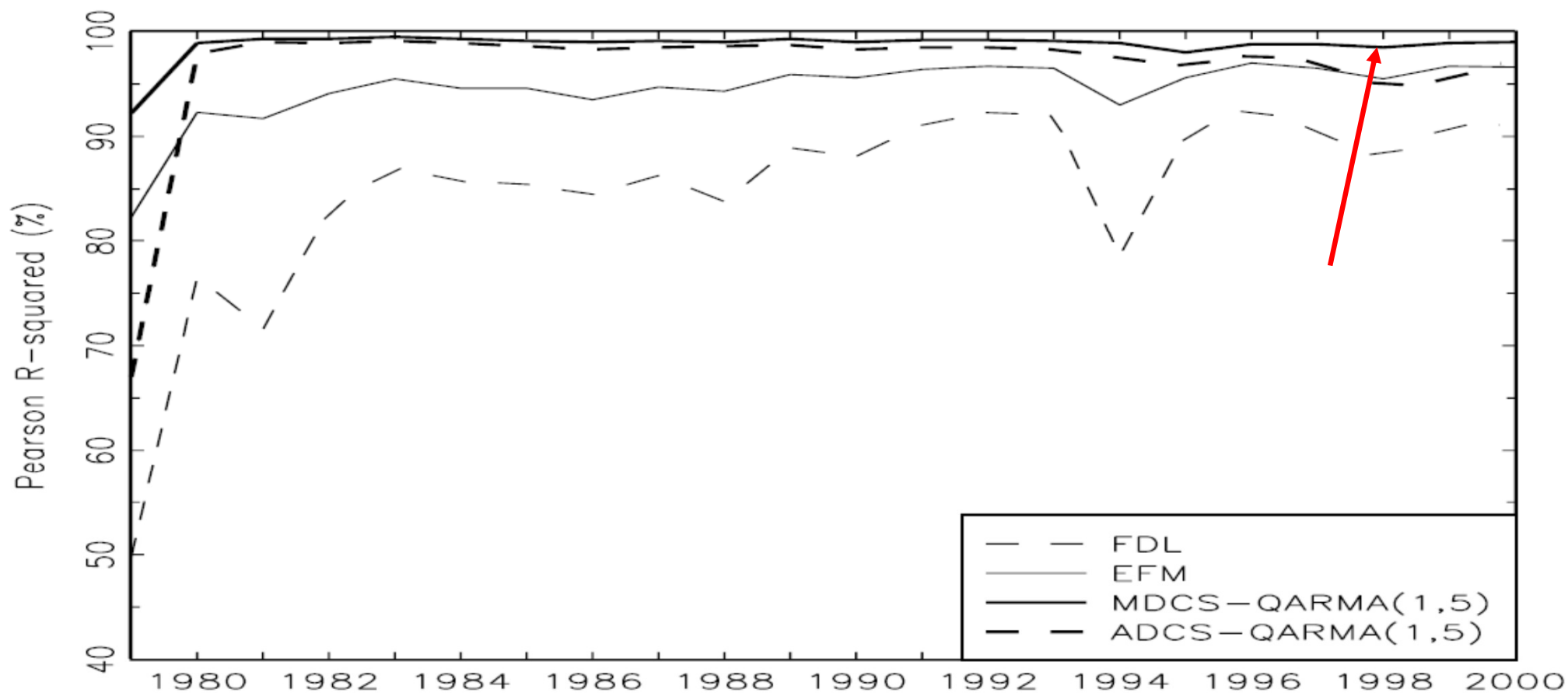
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Table 1 and 2 show the two-step negative binomial QMLE estimation results. (See Tables 1 and 2.)

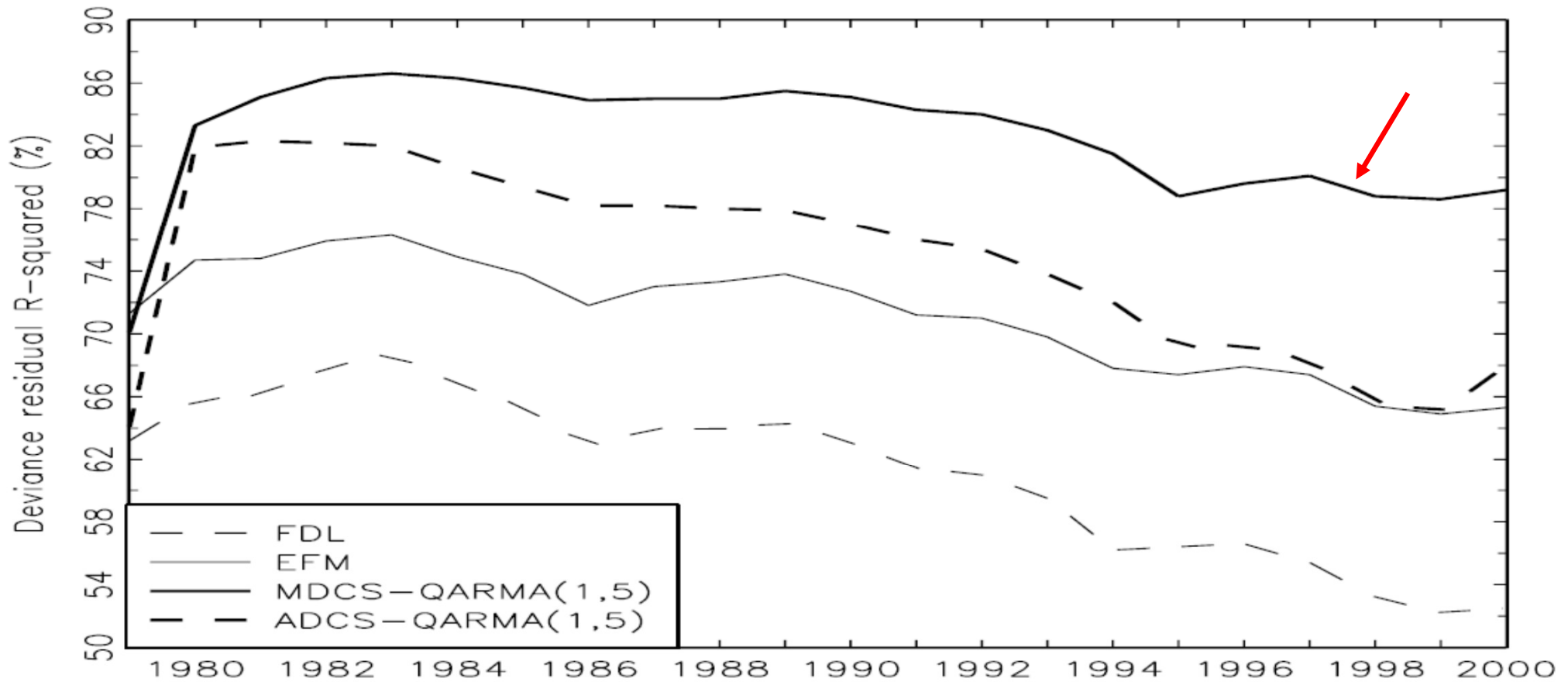
Table 3 Panels A and B, shows test results on contemporaneous exogeneity of R&D expenses; needed for the pooled negative binomial QMLE.

Table 3 Panels C and D, shows mean R-squared model fit metrics for the panel (Cameron and Windmeijer, 1996). An R-squared is computed for each year, then averaged over  $t = 1, \dots, T$

Pearson R-squared over  $t = 1, \dots, T$  for models where contemporaneous R&D is exogenous



Deviance residual R-squared over  $t = 1, \dots, T$  for models where contemporaneous R&D is exogenous



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# Thank you for your attention!

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